



Super Sharp Silicon AFM Probes-10

SSSAP-10

SPECIFICATIONS

short_desc	Super Sharp Silicon AFM Probes
Categories	AFM Probes, Golden
Tags	: Critical Dimension (CDAFM), General Topography, High Resolution Imaging, Trenches/Holes
Quantity	10
Cantilever Length	225
Cantilever Width	30
Cantilever Thickness	1
Resonant Frequency [kHz]	8, 22, 39
Force Constant [N/m]	0.01, 0.11, 0.5
Coating	Al Reflective
Cantilever Shape	Rectangular
Cantilever	Single
Tip	Tetrahedral (Standard)
Tip Material	Single Crystal Silicon

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